

# Discrete Helicoidal Magnetic States in MnSi thin films

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Polarized neutron reflectometry (PNR) and magnetometry measurements in MnSi thin films with analytical solutions of the micromagnetic equations show that the field-induced unwinding in MnSi thin films occurs via discrete steps. PNR measurements were performed on a 26.7 nm thick MnSi film grown by molecular beam epitaxy on on Si(111) substrates. The helical wavelength of the magnetic structure is  $L_D = 13.9$  nm, as determined by pervious PNR measurements [1].

The figure below shows how the magnetic structure evolves discontinuously from a two-turn helicoid state, to a one-turn helicoid states, and then finally into a twisted-ferromagnetic state. Fig (a) shows the magnetization (blue squares) and magnetic susceptibility (black squares) for the  $1.92 L_D$  sample at a temperature of  $T = 5$  K, plotted with the PNR measurement fields indicated by the red circles, and transition fields shown by dotted lines. Fig (b) show the PNR cross-section for  $R_-$  (red squares) and  $R_+$  (black circles) reflectivities for the  $1.92 L_D$  sample measured at  $T = 5$  K,  $\mu_0 H = 0.7$  T. Solid lines show the calculated spin-up (red) and spin-down (black) reflectivity obtained from the solutions to the micromagnetic equations. (c)-(f) Measured (black circles) and calculated (red line) spin asymmetry for the  $1.92 L_D$  sample at  $T = 5$  K,  $\mu_0 H = 700, 400, 200,$  and  $32$  mT. Excellent agreement is achieved without any fitting parameters. (g)-(j) Magnetization depth profiles used to calculate the spin asymmetries shown in figures (c)-(f). The blue line in (c) shows the spin asymmetry calculated for the ferromagnetic state with a depth profile shown by the blue line in (g). More details can be found in Ref. [2].

## References

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